

Octal Bus Buffer with TTL Input Level

TC74HCT540A Inverting, 3-State Outputs

TC74HCT541A Non-Inverting, 3-State Outputs

The TC74HCT540A/TC74HCT541A are high speed CMOS OCTAL BUS BUFFERS fabricated with silicon gate C²MOS technology.

These devices can be used as a level converter for interfacing TTL or NMOS to High Speed CMOS. The inputs are compatible with TTL, NMOS and CMOS output voltage levels.

They achieve the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

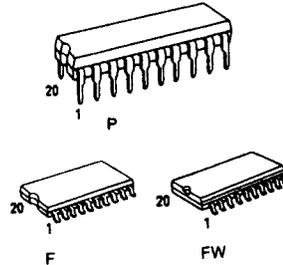
The TC74HCT540A is a non-inverting type, and the TC74HCT541A is an inverting type.

When either $\bar{G}1$ or $\bar{G}2$ are high, the terminal outputs are in the high-impedance state.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

Features

- High Speed: $t_{pd} = 10\text{ns}$ (Typ.) at $V_{CC} = 5\text{V}$
- Low Power Dissipation: $I_{CC} = 4\mu\text{A}$ (Max.) at $T_a = 25^\circ\text{C}$
- Compatible with TTL outputs: $V_{IL} = 0.8$ (Max.)
 $V_{IH} = 2.0$ (Min.)
- Wide Interfacing Ability: LSTTL, NMOS, CMOS
- Output Drive Capability: 15 LSTTL Loads
- Symmetrical Output Impedance: $I_{OH} = I_{OL} = 6\text{mA}$ (Min.)
- Balanced Propagation Delays: $t_{pLH} = t_{pHL}$
- Pin and Function Compatible with 74LS540/541



Truth Table

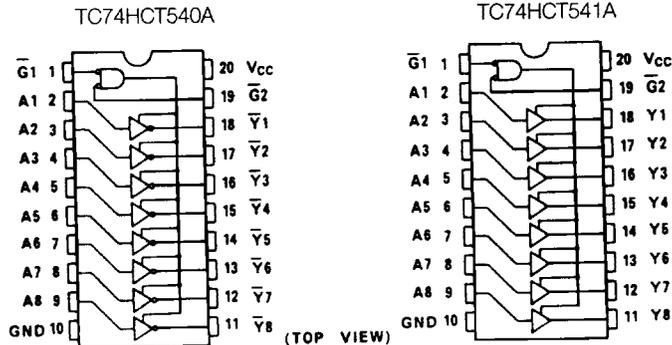
| Inputs | | | Outputs | |
|------------|------------|-------|---------|---------------|
| $\bar{G}1$ | $\bar{G}2$ | A_n | Y_n | \bar{Y}_n^* |
| H | X | X | Z | Z |
| X | H | X | Z | Z |
| L | L | H | H | L |
| L | L | L | L | H |

X: "H" or "L"

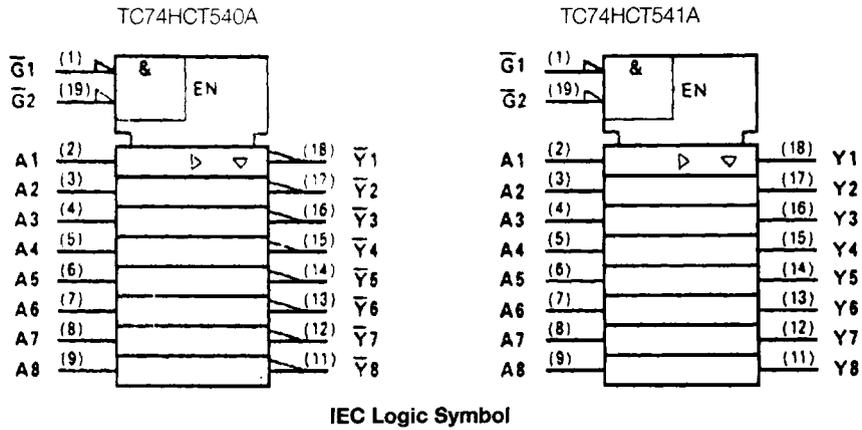
Z: High Impedance

*: Y_nHC541A

: \bar{Y}_nHC540A



Pin Assignment



Absolute Maximum Ratings

| Parameter | Symbol | Value | Unit |
|-----------------------------|-----------|-----------------------|------|
| Supply Voltage Range | V_{CC} | -0.5 - 7 | V |
| DC Input Voltage | V_{IN} | -0.5 - $V_{CC} + 0.5$ | V |
| DC Output Voltage | V_{OUT} | -0.5 - $V_{CC} + 0.5$ | V |
| Input Diode Current | I_{IK} | ±20 | mA |
| Output Diode Current | I_{OK} | ±20 | mA |
| DC Output Current | I_{OUT} | ±35 | mA |
| DC V_{CC} /Ground Current | I_{CC} | ±75 | mA |
| Power Dissipation | P_D | 500(DIP)*180(SOIC) | mW |
| Storage Temperature | T_{stg} | -65 - 150 | °C |
| Lead Temperature 10sec | T_L | 300 | °C |

*500mW in the range of $T_a = -40^{\circ}\text{C} - 65^{\circ}\text{C}$. From $T_a = 65^{\circ}\text{C}$ to 85°C a derating factor of -10mW/°C shall be applied until 300mW.

Recommended Operating Conditions

| Parameter | Symbol | Value | Unit |
|--------------------------|------------|--------------|------|
| Supply Voltage | V_{CC} | 4.5 - 5.5 | V |
| Input Voltage | V_{IN} | 0 - V_{CC} | V |
| Output Voltage | V_{OUT} | 0 - V_{CC} | V |
| Operating Temperature | T_{opr} | -40 - 85 | °C |
| Input Rise and Fall Time | t_r, t_f | 0 - 500 | ns |

DC Electrical Characteristics

| Parameter | Symbol | Test Condition | V_{CC} | $T_a = 25^{\circ}\text{C}$ | | | $T_a = -40 \sim 85^{\circ}\text{C}$ | | Unit | |
|----------------------------------|-----------------|--|---------------------------|----------------------------|------|------|-------------------------------------|------|------|---|
| | | | | Min. | Typ. | Max. | Min. | Max. | | |
| High-Level Input Voltage | V_{IH} | - | 4.5 ∫ 5.5 | 2.0 | - | - | 2.0 | - | V | |
| Low-Level Input Voltage | V_{IL} | - | 4.5 ∫ 5.5 | - | - | 0.8 | - | 0.8 | V | |
| High-Level Output Voltage | V_{OH} | $V_{IN} = V_{IH}$ or V_{IL} | $I_{OH} = -20\mu\text{A}$ | 4.5 | 4.4 | 4.5 | - | 4.4 | - | V |
| | | | $I_{OH} = -6\text{mA}$ | 4.5 | 4.18 | 4.31 | - | 4.13 | - | V |
| Low-Level Output Voltage | V_{OL} | $V_{IN} = V_{IH}$ or V_{IL} | $I_{OL} = 20\mu\text{A}$ | 4.5 | - | 0.0 | 0.1 | - | 0.1 | V |
| | | | $I_{OL} = 6\text{mA}$ | 4.5 | - | 0.17 | 0.26 | - | 0.33 | V |
| 3-State Output Off-State Current | I_{OZ} | $V_{IN} = V_{IH}$ or V_{IL} $V_{OUT} = V_{CC}$ or GND | 5.5 | - | - | ±0.5 | - | ±5.0 | μA | |
| Input Leakage Current | I_{IN} | $V_{IN} = V_{CC}$ or GND | 5.5 | - | - | ±0.1 | - | ±1.0 | | |
| Quiescent Supply Current | I_{CC} | $V_{IN} = V_{CC}$ or GND | 5.5 | - | - | 4.0 | - | 40.0 | | |
| | ΔI_{CC} | Per Input: $V_{IN} = 0.5\text{V}$ or 2.4V Other Input: V_{CC} or GND | 5.5 | - | - | 2.0 | - | 2.9 | mA | |

AC Electrical Characteristics (C_L = 50pF, Input t_r = t_f = 6ns)

| Parameter | Symbol | Test Condition | Ta = 25°C | | | Ta = -40 ~ 85°C | | Unit | | | |
|-------------------------------|--------------------------------------|-----------------------|-----------|-----------------|--------|-----------------|----------|--------|----------|------|----|
| | | | CL | V _{CC} | Min. | Typ. | Max. | | Min. | Max. | |
| Output Transition Time | t _{TLH} t _{THL} | — | 50 | 4.5 5.5 | — — | 7 6 | 12 11 | — — | 15 14 | ns | |
| Propagation Delay Time | t _{pLH} | TC74HCT540A | 50 | 4.5 5.5 | — — | 12 9 | 20 18 | 25 | 23 | | |
| | t _{pHL} | | 150 | 4.5 5.5 | — — | 17 14 | 26 18 | — — | 33 30 | | |
| Propagation Delay Time | t _{pLH} | TC74HCT541A | 50 | 4.5 5.5 | — — | 14 11 | 23 21 | — — | 29 27 | | |
| | t _{pHL} | | 150 | 4.5 5.5 | — — | 19 16 | 29 27 | — — | 36 33 | | |
| 3-State Output Enable Time | t _{pZL} | R _L = 1k Ω | 50 | 4.5 5.5 | — — | 18 16 | 30 27 | — — | 38 35 | | |
| | t _{pZH} | | 150 | 4.5 5.5 | — — | 23 21 | 36 33 | — — | 45 41 | | |
| 3-State Output Disable Time | t _{pLZ} t _{pHZ} | R _L = 1k Ω | 50 | 4.5 5.5 | — — | 18 16 | 30 27 | — — | 38 35 | | |
| Input Capacitance | C _{IN} | — | — | — | — | 5 | 10 | — | 10 | | pF |
| Output Capacitance | C _{OUT} | — | — | — | — | 10 | — | — | — | | |
| Power Dissipation Capacitance | C _{PD(1)} | TC74HCT540A | — | — | — | 35 | — | — | — | | |
| | | TC74HCT541A | — | — | — | 31 | — | — | — | | |

Note (1) C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation:

$$I_{CC(oper)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8(\text{per bit})$$